

## MOS FIELD EFFECT TRANSISTOR 2SJ599

## SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

#### **DESCRIPTION**

The 2SJ599 is P-channel MOS Field Effect Transistor designed for solenoid, motor and lamp driver.

#### **FEATURES**

• Low on-state resistance:

 $R_{DS(on)1} = 75 \text{ m}\Omega$  MAX. (VGs = -10 V, ID = -10 A)  $R_{DS(on)2} = 111 \text{ m}\Omega$  MAX. (VGs = -4.0 V, ID = -10 A)

- ★ Low input capacitance:
  - $C_{iss} = 1300 \text{ pF TYP.}$  ( $V_{DS} = -10 \text{ V}$ ,  $V_{GS} = 0 \text{ V}$ )
  - · Built-in gate protection diode
  - TO-251/TO-252 package

#### ORDERING INFORMATION

PART NUMBER	PACKAGE
2SJ599	TO-251
2SJ599-Z	TO-252

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	Voss	-60	V
Gate to Source Voltage (Vps = 0 V)	Vgss	∓20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	∓20	Α
Drain Current (pulse) Note1	D(pulse)	∓50	Α
Total Power Dissipation (Tc = 25°C)	Рт	35	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	Рт	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C
Single Avalanche Current Note2	las	-20	Α
Single Avalanche Energy Note2	Eas	40	mJ

(TO-252)

(TO-251)



**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%

**2.** Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = -30 V, R<sub>G</sub> = 25 Ω, V<sub>GS</sub> = -20 → 0 V

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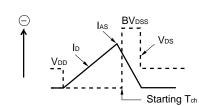


#### **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

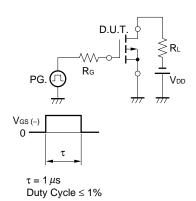
	CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
	Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V			-10	μΑ
	Gate Leakage Current	Igss	V <sub>GS</sub> = ∓20 V, V <sub>DS</sub> = 0 V			<del>+</del> 10	μΑ
*	Gate Cut-off Voltage	V <sub>GS(off)</sub>	$V_{DS} = -10 \text{ V}, \text{ ID} = -1 \text{ mA}$	-1.5	-2.0	-2.5	V
	Forward Transfer Admittance	y <sub>fs</sub>	$V_{DS} = -10 \text{ V}, I_{D} = -10 \text{ A}$	8	16		S
	Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -10 \text{ V}, I_{D} = -10 \text{ A}$		60	75	mΩ
		RDS(on)2	$V_{GS} = -4.0  \text{V},  I_{D} = -10  \text{A}$		78	111	$m\Omega$
	Input Capacitance	Ciss	V <sub>DS</sub> = -10 V		1300		pF
	Output Capacitance	Coss	V <sub>G</sub> s = 0 V		240		pF
	Reverse Transfer Capacitance	Crss	f = 1 MHz		100		pF
	Turn-on Delay Time	td(on)	ID = -10 A		8		ns
	Rise Time	<b>t</b> r	Vgs = -10 V		9		ns
	Turn-off Delay Time	td(off)	VDD = -30 V		52		ns
	Fall Time	<b>t</b> f	$R_G = 0 \Omega$		16		ns
	Total Gate Charge	Q <sub>G</sub>	ID = -20A		26		nC
	Gate to Source Charge	Qgs	V <sub>DD</sub> = -48 V		5		nC
	Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS</sub> = -10 V		7		nC
*	Body Diode Forward Voltage	V <sub>F(S-D)</sub>	IF = 20 A, VGS = 0 V		1.0		V
*	Reverse Recovery Time	trr	IF = 20 A, VGS = 0 V		51		ns
*	Reverse Recovery Charge	Qrr	di/dt = 100 A / μs		102		nC

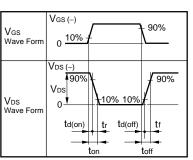
#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \, \Omega \\ \text{Vgs} = -20 \rightarrow 0 \, \text{V} \\ \end{array}$

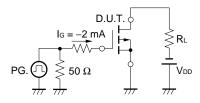


#### **TEST CIRCUIT 2 SWITCHING TIME**

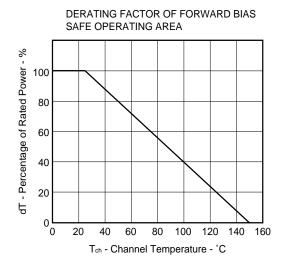


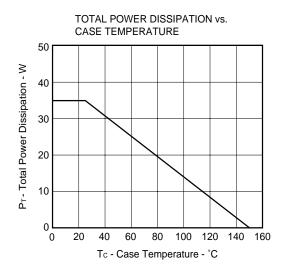


#### **TEST CIRCUIT 3 GATE CHARGE**

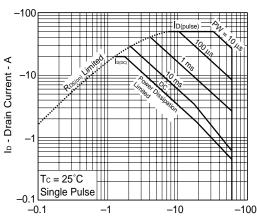


#### \* TYPICAL CHARACTERISTICS (TA = 25°C)



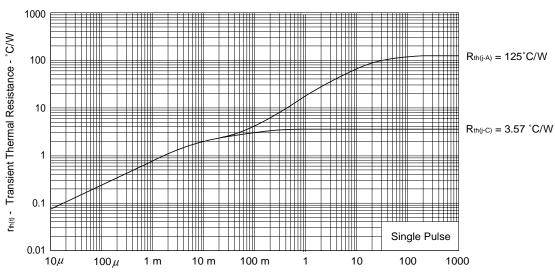


#### FORWARD BIAS SAFE OPERATING AREA



#### V<sub>DS</sub> - Drain to Source Voltage - V

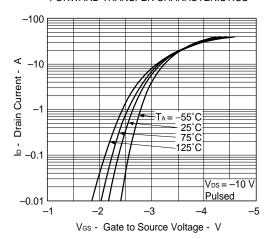
#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



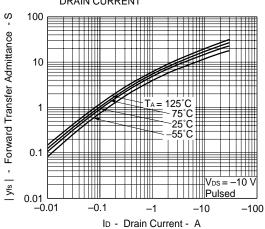
PW - Pulse Width - s

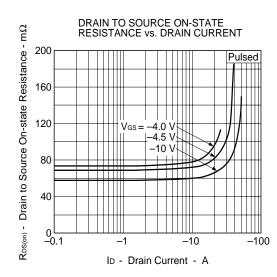
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#### FORWARD TRANSFER CHARACTERISTICS

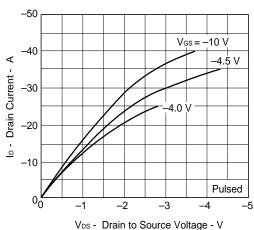


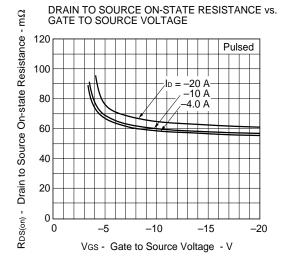
### FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



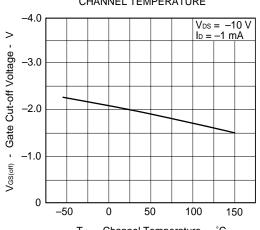


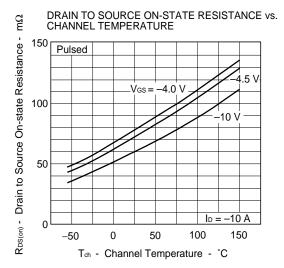
#### DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

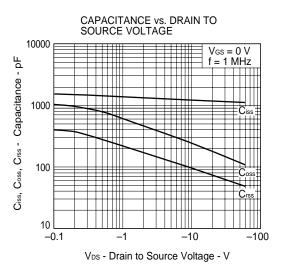


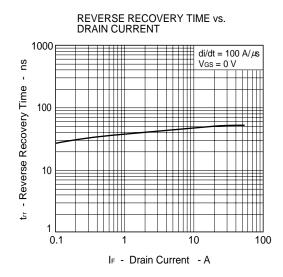


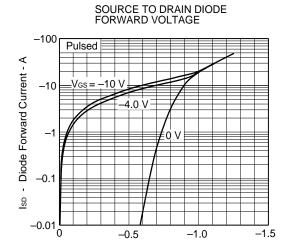
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



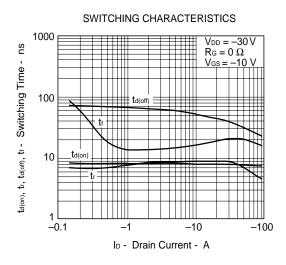


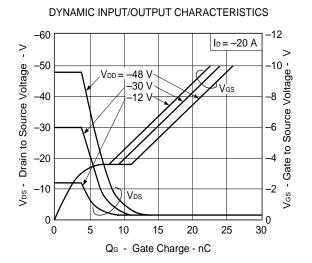


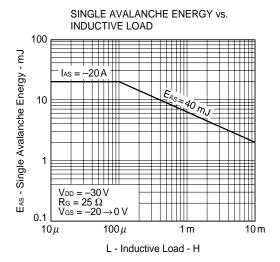


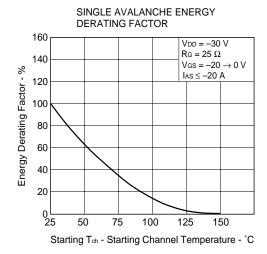


VsD - Source to Drain Voltage - V





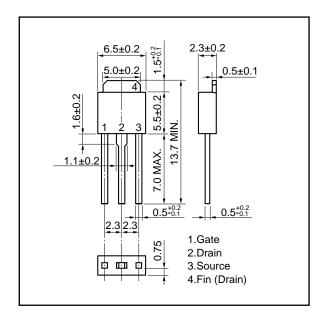




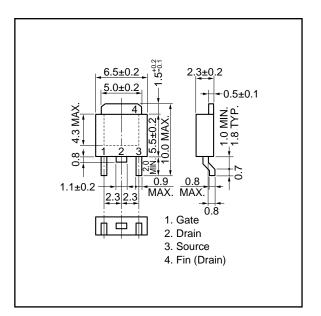


#### **PACKAGE DRAWINGS (Unit: mm)**

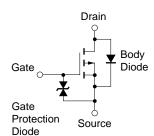
#### 1) TO-251 (MP-3)



#### 2) TO-252 (MP-3Z)



#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

Data Sheet D14644EJ2V0DS

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